

**Search Notes**

Application/Control No.

10/511,734

Examiner

Shun Lee

Applicant(s)/Patent under  
Reexamination

PROTIC ET AL.

Art Unit

2884

**SEARCHED**

Class	Subclass	Date	Examiner
250	370.01	6/16/2006	SL
250	370.06	6/16/2006	SL
250	370.13	6/16/2006	SL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	6/16/2006	SL